

MOS FIELD EFFECT TRANSISTOR 2SK3404

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SK3404 is N-Channel MOS FET device that features a low on-state resistance and excellent switching characteristics, designed for low voltage high current applications such as DC/DC converter with synchronous rectifier.

FEATURES

- 4.5-V drive available
- Low on-state resistance
 $R_{DS(on)1} = 14 \text{ m}\Omega \text{ MAX. (} V_{GS} = 10 \text{ V, } I_D = 20 \text{ A)}$
- Low gate charge
 $Q_G = 25 \text{ nC TYP. (} I_D = 40 \text{ A, } V_{DD} = 24 \text{ V, } V_{GS} = 10 \text{ V)}$
- Built-in gate protection diode
- Surface mount device available

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$)

Drain to Source Voltage ($V_{GS} = 0 \text{ V}$)	V_{DSS}	30	V
Gate to Source Voltage ($V_{DS} = 0 \text{ V}$)	V_{GSS}	± 20	V
Drain Current (DC) ($T_C = 25^\circ\text{C}$)	$I_{D(DC)}$	± 40	A
Drain Current (Pulse) ^{Note}	$I_{D(pulse)}$	± 160	A
Total Power Dissipation ($T_A = 25^\circ\text{C}$)	P_{T1}	1.5	W
Total Power Dissipation ($T_C = 25^\circ\text{C}$)	P_{T2}	40	W
Channel Temperature	T_{ch}	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 to +150	$^\circ\text{C}$

Note $PW \leq 10 \mu\text{s}$, Duty Cycle $\leq 1\%$

★ ORDERING INFORMATION

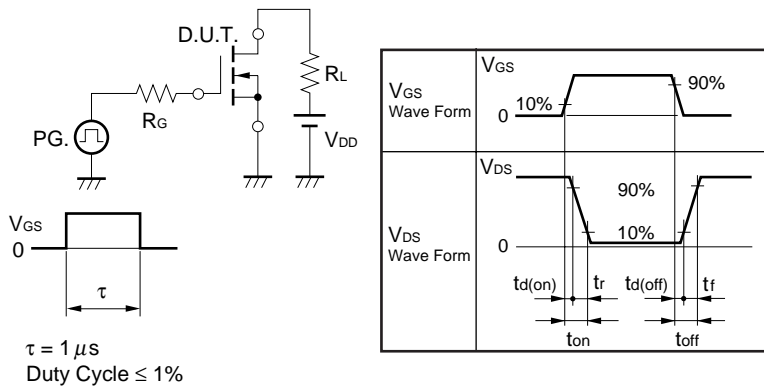
PART NUMBER	PACKAGE
2SK3404	TO-220AB
2SK3404-ZK	TO-263(MP-25ZK)
2SK3404-ZJ	TO-263(MP-25ZJ)

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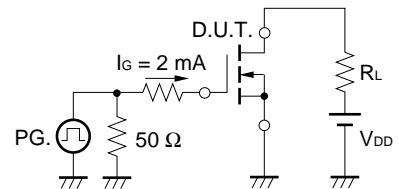
ELECTRICAL CHARACTERISTICS(T_A = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain Leakage Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V			10	μA
Gate Leakage Current	I _{GSS}	V _{GS} = ±20 V, V _{DS} = 0 V			±10	μA
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.5		2.5	V
Forward Transfer Admittance	y _{fs}	V _{DS} = 10 V, I _D = 20 A	8.0			S
Drain to Source On-state Resistance	R _{DS(on)1}	V _{GS} = 10 V, I _D = 20 A		11	14	mΩ
	R _{DS(on)2}	V _{GS} = 4.5 V, I _D = 20 A		15	21	mΩ
Input Capacitance	C _{iss}	V _{DS} = 10 V		1400		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V		410		pF
Reverse Transfer Capacitance	C _{rss}	f = 1 MHz		180		pF
★ Turn-on Delay Time	t _{d(on)}	V _{DD} = 15 V, I _D = 20 A		20		ns
Rise Time	t _r	V _{GS(on)} = 10 V		9		ns
Turn-off Delay Time	t _{d(off)}	R _G = 10 Ω		50		ns
Fall Time	t _f			14		ns
Total Gate Charge	Q _G	V _{DD} = 24 V		25		nC
Gate to Source Charge	Q _{GS}	V _{GS} = 10 V		5.0		nC
Gate to Drain Charge	Q _{GD}	I _D = 40 A		7.0		nC
Diode Forward Voltage	V _{F(S-D)}	I _F = 40 A, V _{GS} = 0 V		1.0		V
Reverse Recovery Time	t _{rr}	I _F = 40 A, V _{GS} = 0 V		31		ns
Reverse Recovery Charge	Q _{rr}	di/dt = 100 A/μs		28		nC

TEST CIRCUIT 1 SWITCHING TIME

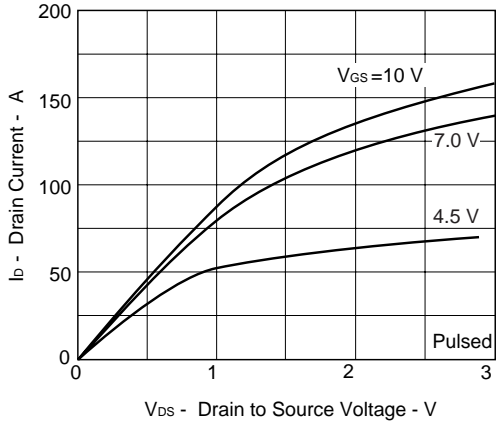


TEST CIRCUIT 2 GATE CHARGE

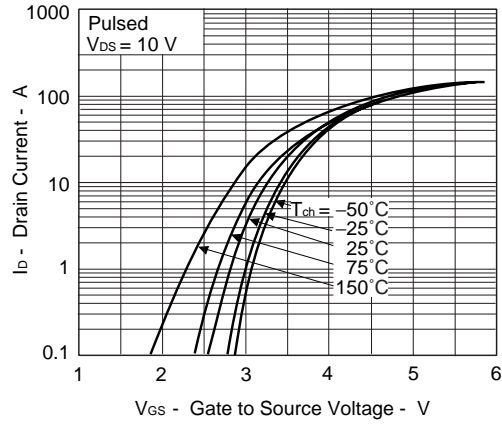


★ TYPICAL CHARACTERISTICS (T_A = 25°C)

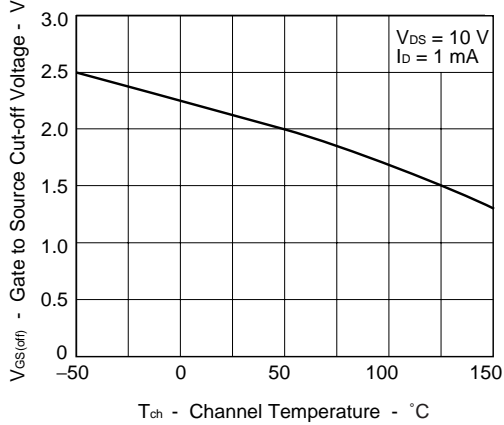
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



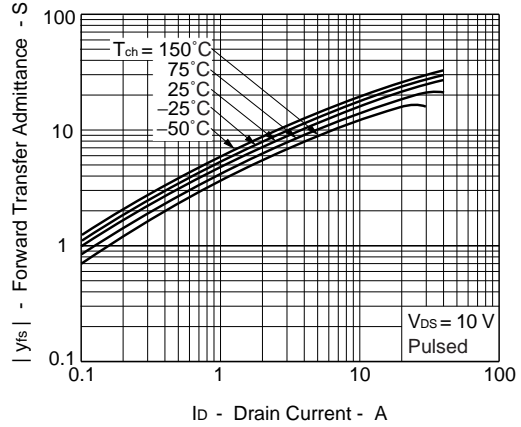
FORWARD TRANSFER CHARACTERISTICS



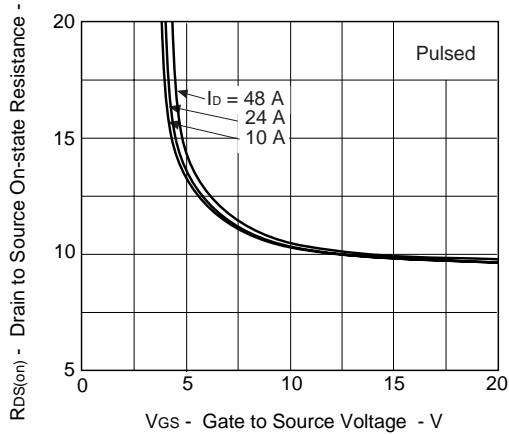
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



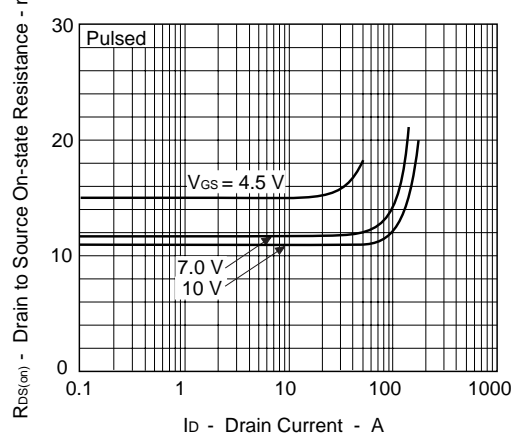
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

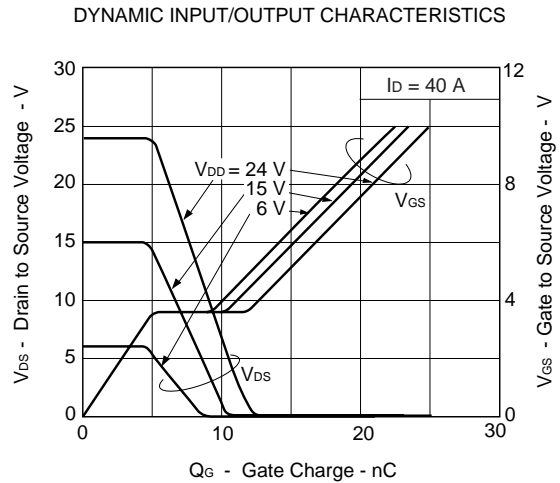
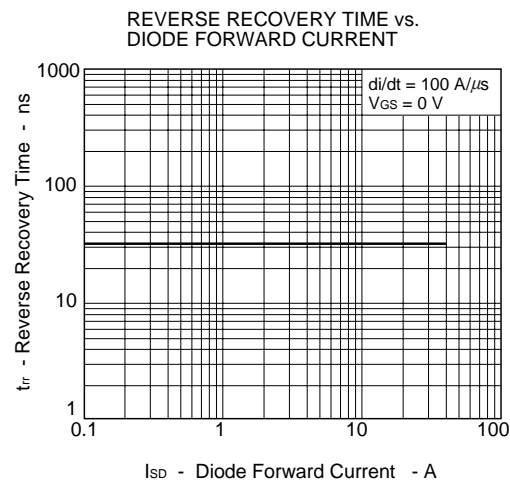
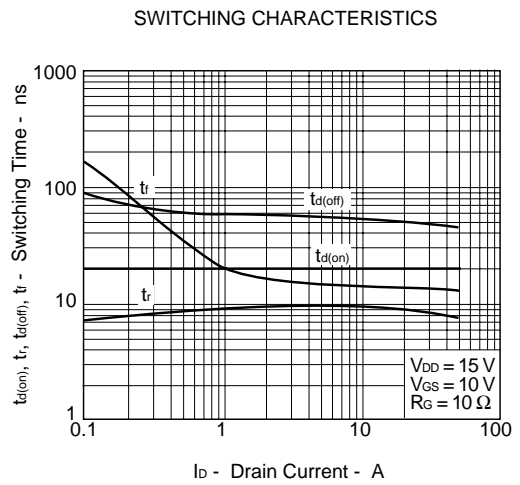
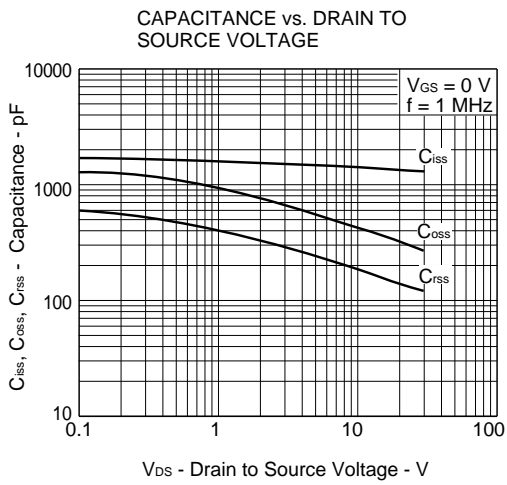
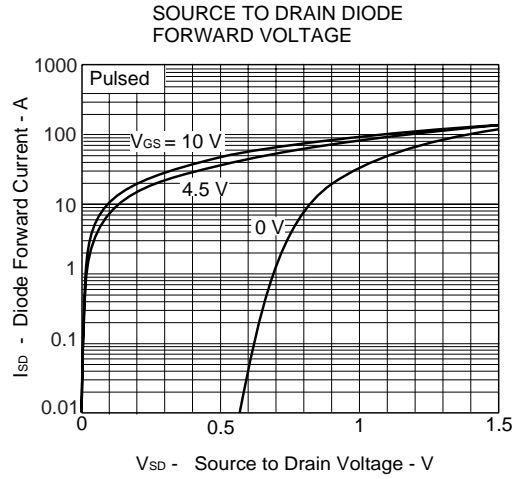
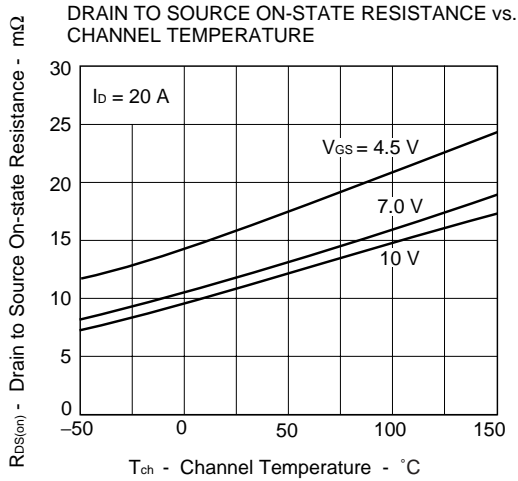


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

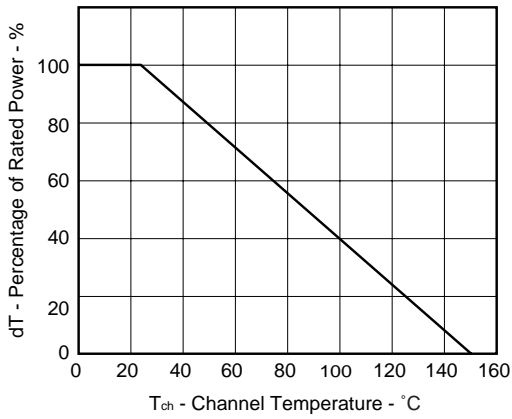


DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

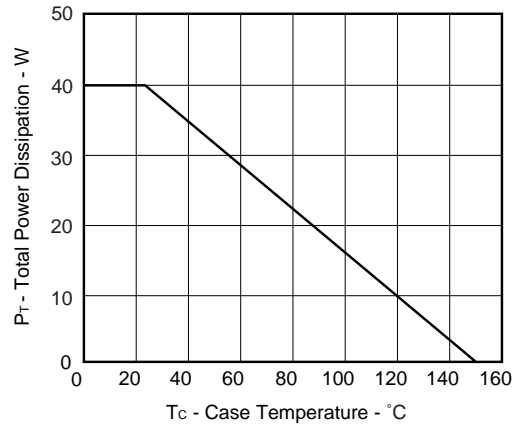




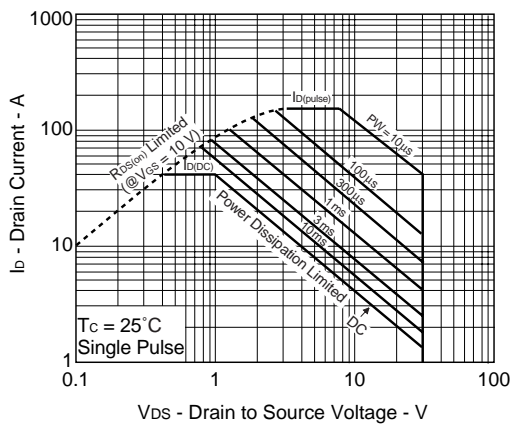
DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



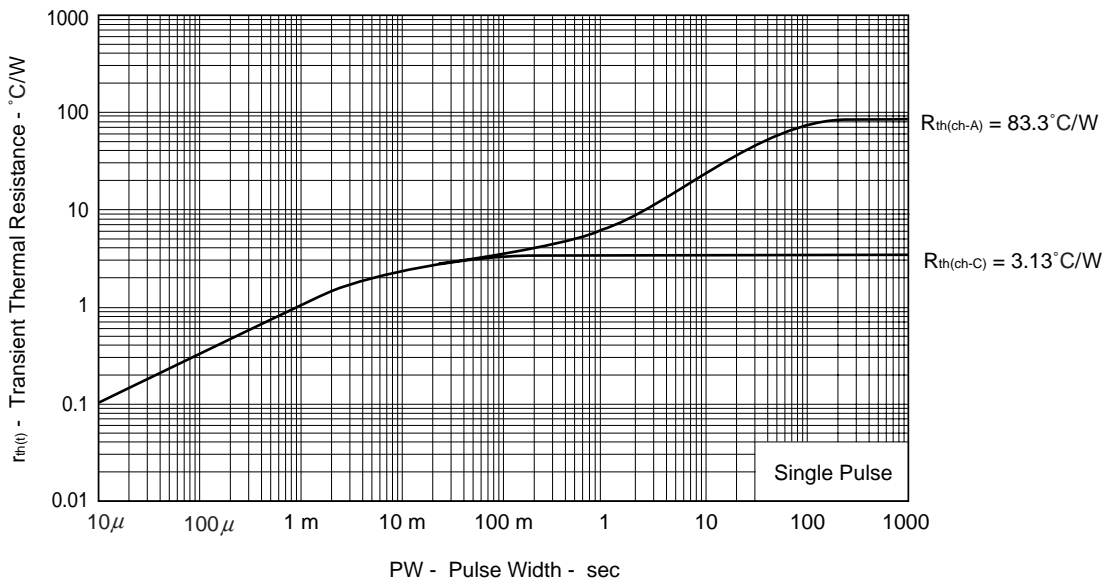
TOTAL POWER DISSIPATION vs. CASE TEMPERATURE



FORWARD BIAS SAFE OPERATING AREA

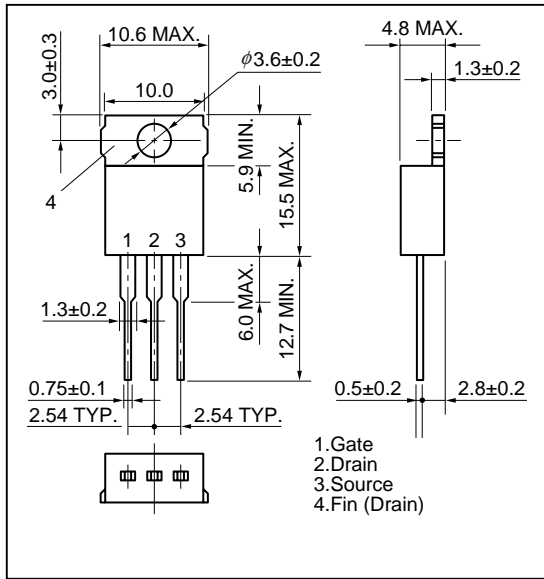


TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

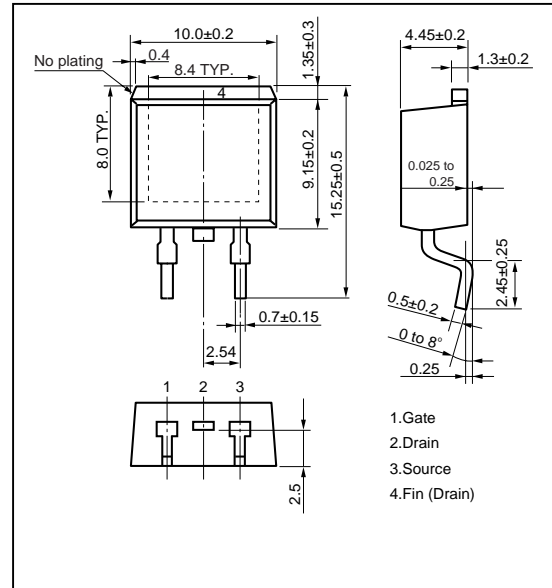


PACKAGE DRAWINGS (Unit : mm)

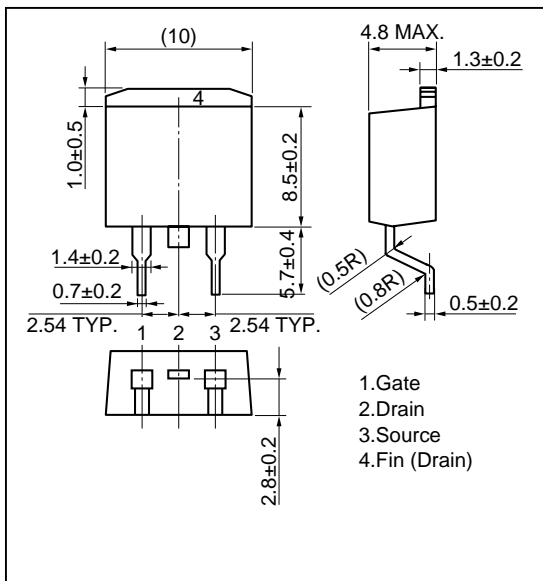
1) TO-220AB (MP-25)



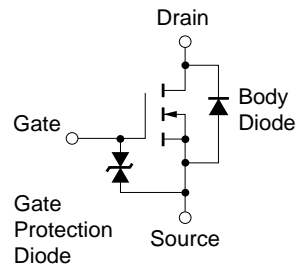
★ 2) TO-263 (MP-25ZK)



3) TO-263 (MP-25ZJ)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

[MEMO]

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